Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10756932	FOCAZIO ET AL.
Examiner	**Art Unit**
Lin, Shew-Fen	2166

ORIGINAL	
CLASS	SUBCLASS
707	100

CROSS REFERENCE(S)					
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
707	102				

INTERNATIONAL CLASSIFICATION					
CLAIMED					NON-CLAIMED
G	0	6	F	7 / 00 (2006.01.01)	
G	0	6	F	17 / 00 (2006.01.01)	

Lin, Shew-Fen (Assistant Examiner) SFL	6/26/07 (Date)	**Total Claims Allowed:** 10
G. White (Legal Instruments Examiner)	7/6/07 (Date)	(Primary Examiner) (Date)

O.G. Print Claim(s)	O.G. Print Figure
1	8

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SUPERVISORY PATENT EXAMINER